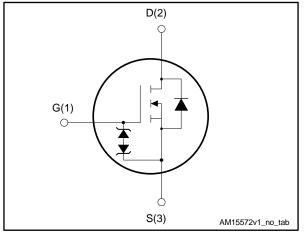


# N-channel 650 V, 0.6 Ω typ., 10 A SuperMESH™ Power MOSFET in a TO-220FP package

Datasheet - production data

# TO-220FP

Figure 1: Internal schematic diagram



## **Features**

Order code	VDS	RDS(on) max.	ΙD	Ртот
STF12NK65Z	650 V	0.7 Ω	10 A	35 W

- Extremely high dv/dt capability
- 100% avalanche tested
- Gate charge minimized
- Zener-protected

# **Applications**

• Switching applications

# Description

This high voltage device is a Zener-protected N-channel Power MOSFET developed using the SuperMESH<sup>™</sup> technology by STMicroelectronics, an optimization of the well-established PowerMESH<sup>™</sup>. In addition to a

significant reduction in on-resistance, this device is designed to ensure a high level of dv/dt capability for the most demanding applications.

### Table 1: Device summary

Order code	Marking	Package	Packaging
STF12NK65Z	12NK65Z	TO-220FP	Tube

This is information on a product in full production.

### Contents

# Contents

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# 1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
Vds	Drain-source voltage	650	V
V <sub>GS</sub>	Gate-source voltage	±30	V
ΙD	Drain current (continuous) at $T_c = 25 \ ^{\circ}C$	10	А
ΙD	Drain current (continuous) at T <sub>c</sub> = 100 °C	6.3	А
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	40	А
Ртот	Total dissipation at $T_C = 25 \ ^{\circ}C$	35	W
Viso	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s, $T_C$ = 25 °C)	2500	V
dv/dt <sup>(2)</sup>	Peak diode recovery voltage slope	4.5	V/ns
T <sub>stg</sub>	Storage temperature range	55 to 150	°C
Tj	Operation junction temperature range	-55 to 150	C

### Notes:

 $^{(1)}\mbox{Pulse}$  width limited by safe operating area

 $\label{eq:ISD} ^{(2)} I_{SD} \leq 10 \text{ A}, \text{ di/dt} \leq 200 \text{ A/} \mu \text{s}, \text{ V}_{DD} \leq \text{V}_{(BR)DSS}, \text{ } T_{j} \leq \text{T}_{JMAX}$ 

### Table 3: Thermal data

Symbol	Parameter		Unit
R <sub>thj-case</sub>	Thermal resistance junction-case	3.6	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient	62.5	°C/W

### Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I <sub>AR</sub>	Avalanche current, repetitive or non-repetitive (pulse width limited by T <sub>JMAX</sub> )	10	А
Eas	Single pulse avalanche energy (starting $T_J = 25 \text{ °C}$ , $I_D = I_{AR}$ , $V_{DD} = 50 \text{ V}$ )	225	mJ



# 2 Electrical characteristics

(T<sub>c</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$V_{GS} = 0 V, I_D = 1 mA$	650			V
I <sub>DSS</sub> Zero gate voltage drain current	Zoro goto voltago drain	$V_{GS} = 0 V, V_{DS} = 650 V$			1	μΑ
	8 0				50	μA
I <sub>GSS</sub>	Gate-body leakage current	$V_{DS}$ = 0 V, $V_{GS}$ = ±20 V			±10	μA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 100 \ \mu A$	3	3.75	4.5	V
R <sub>DS(on)</sub>	Static drain-source on- resistance	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		0.6	0.7	Ω

### Notes:

 $\ensuremath{^{(1)}}\xspace$  Defined by design, not subject to production test.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	1837	-	pF
Coss	Output capacitance	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V,	-	208	-	pF
C <sub>rss</sub>	Reverse transfer capacitance	f = 1 MHz	-	48.8	-	pF
Coss eq <sup>(1)</sup>	Equivalent output capacitance	$V_{GS} = 0 \text{ V},  V_{DS} = 0 \text{ to } 520 \text{ V}$	-	122	-	pF
Qg	Total gate charge	$V_{DD} = 520 \text{ V}, \text{ I}_{D} = 10 \text{ A},$	-	62.6	-	nC
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> = 0 to 10 V	-	9.6	-	nC
Q <sub>gd</sub>	Gate-drain charge	(see Figure 15: "Test circuit for gate charge behavior")	-	36	-	nC
R <sub>G</sub>	Intrinsic gate resistance	f = 1 MHz, I <sub>D</sub> = 0 A	-	1	-	Ω

### Table 6: Dynamic

### Notes:

 $^{(1)}C_{oss\ eq}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%



### Electrical characteristics

	Table 7: Switching times								
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit			
t <sub>d(on)</sub>	Turn-on delay time	$V_{DD} = 325 V, I_D = 5 A,$	-	25	-	ns			
tr	Rise time	$R_G = 4.7 \ \Omega, \ V_{GS} = 10 \ V$	-	14	-	ns			
t <sub>d(off)</sub>	Turn-off delay time	(see Figure 14: "Test circuit for resistive load switching times"	-	55	-	ns			
tr	Fall time	and Figure 19: "Switching time waveform")	-	11.5	-	ns			

### Table 8: Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Isd	Source-drain current		-		10	А
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		40	А
Vsd <sup>(2)</sup>	Forward on voltage	$I_{SD} = 10 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$	-		1.6	V
trr	Reverse recovery time	I <sub>SD</sub> = 10 A, di/dt = 100 A/µs,	-	436		ns
Qrr	Reverse recovery charge	$V_{DD} = 60 V$	-	3.4		μC
I <sub>RRM</sub>	Reverse recovery current	(see Figure 16: "Test circuit for inductive load switching and diode recovery times")	-	15.4		A
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 10 A, di/dt = 100 A/µs,	-	518		ns
Qrr	Reverse recovery charge	$V_{DD} = 60 \text{ V}$ , $T_J = 150 \text{ °C}$ (see Figure 16: "Test circuit for inductive load switching and diode recovery times")	-	4.1		μC
Irrm	Reverse recovery current		-	15.9		A

### Notes:

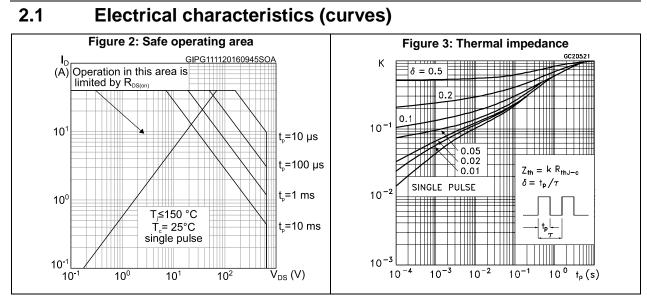
 $^{(1)}\text{Pulsed:}$  pulse duration=300  $\mu\text{s},$  duty cycle 1.5%.  $^{(2)}\text{Pulse}$  width limited by safe operating area.

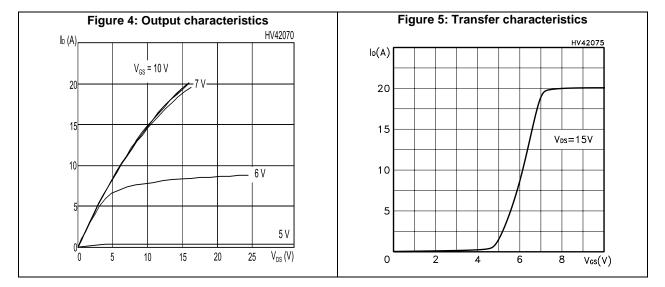
Table 9:	Gate-source	Zener	diode
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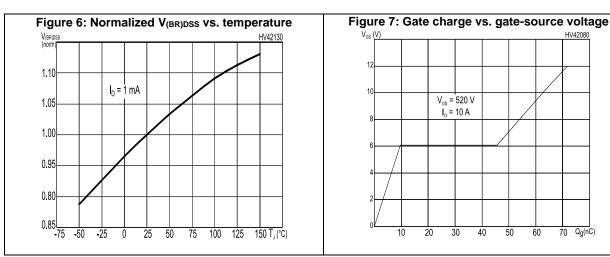
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)GSO</sub>	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_D = 0 \text{ A}$	30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.











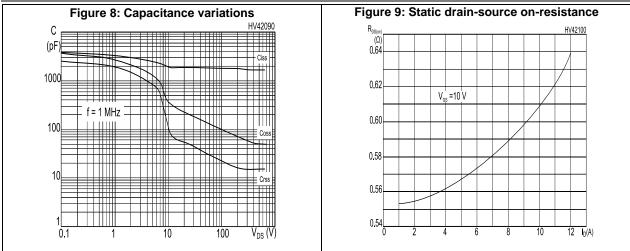
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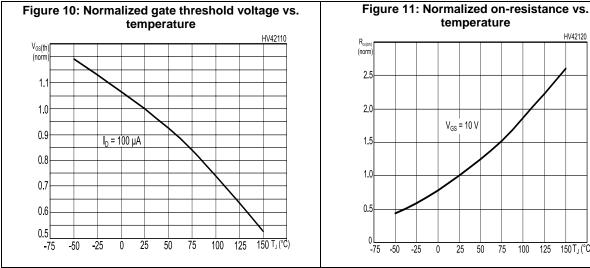
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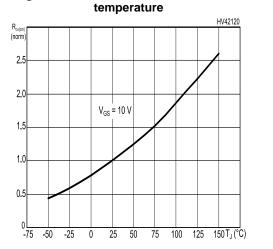
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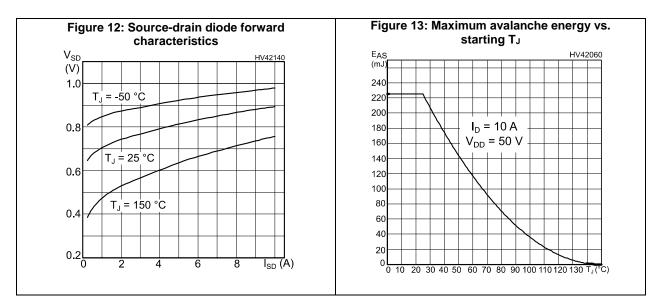
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### **Electrical characteristics**



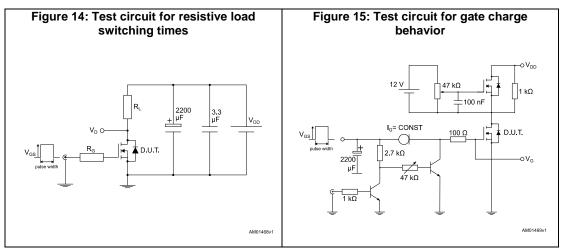


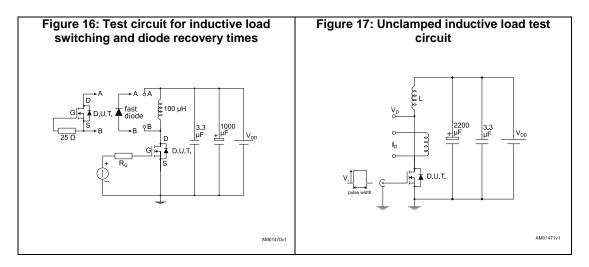


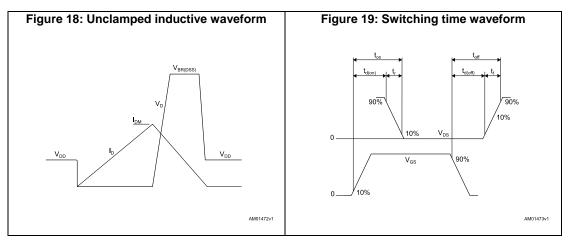


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# 3 Test circuits







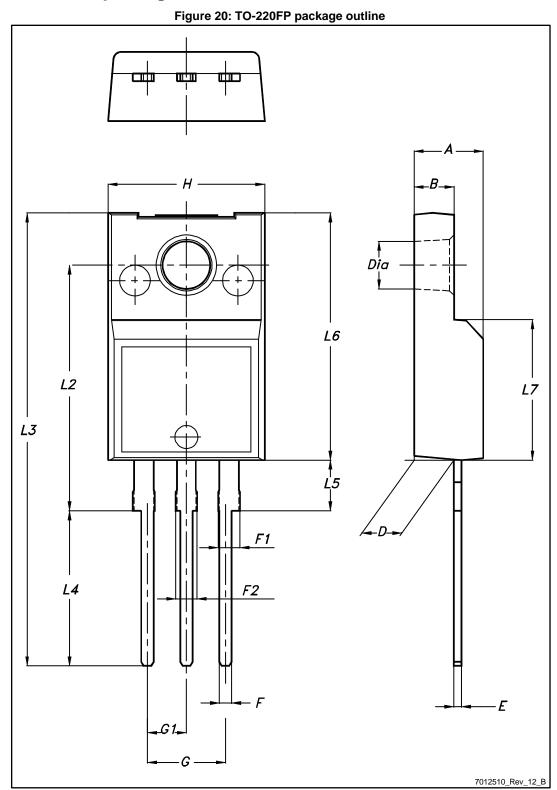


# 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.









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5Z			Package information		
Table 10: TO-220FP package mechanical data					
Dim.		mm			
	Min.	Тур.	Max.		
A	4.4		4.6		
В	2.5		2.7		
D	2.5		2.75		
E	0.45		0.7		
F	0.75		1		
F1	1.15		1.70		
F2	1.15		1.70		
G	4.95		5.2		
G1	2.4		2.7		
Н	10		10.4		
L2		16			
L3	28.6		30.6		
L4	9.8		10.6		
L5	2.9		3.6		
L6	15.9		16.4		
L7	9		9.3		
Dia	3		3.2		



# 5 Revision history

Table 11: Document revision history

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Date	Revision	Changes	
01-Oct-2010	1	Initial release.	
10-Nov-2016	2	Modified title, features and description in cover page Modified Table 2: "Absolute maximum ratings", Table 3: "Thermal data", Table 5: "On /off states", Table 6: "Dynamic", Table 8: "Source drain diode", Table 9: "Gate-source Zener diode" Modified Figure 2: "Safe operating area" Updated Section 4.1: "TO-220FP package information" Minor text changes	
05-Apr-2017	3	Datasheet status promoted from preliminary to production data. Updated Section 2.1: "Electrical characteristics (curves)". Minor text changes	





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